#### Part I: Ad-Hoc Approaches for Variability

- 1. Introduction
- 2. Runtime Variability and Design Patterns
- 3. Compile-Time Variability with Clone-and-Own

#### Part II: Modeling & Implementing Features

- 4. Feature Modeling
- 5. Conditional Compilation
- 6. Modular Features
- 7. Languages for Features
- 8. Development Process

#### Part III: Quality Assurance and Outlook

- 9. Feature Interactions
- 10. Product-Line Analyses
- 11. Product-Line Testing
- 12. Evolution and Maintenance

### 11a. Challenges of Product-Line Testing

Recap: Software Testing

Test-Case Design in Single-System Engineering

Testing All Configurations

Testing One Configuration

Sample-Based Testing

Summary

#### 11b. Combinatorial Interaction Testing

Pairwise Interaction Testing

T-Wise Interaction Testing

Algorithms for Combinatorial Interaction Testing

Efficiency of Combinatorial Interaction Testing

Effectiveness of Combinatorial Interaction

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Summary

### 11c. Solution-Space Sampling

Coverage in Single-System Engineering Coverage of Ifdef Blocks

Presence-Condition Coverage

Overview on Coverage Criteria

Input for Sampling Algorithms

Summary FAQ

# 11. Product-Line Testing – Handout

Software Product Lines | Thomas Thüm, Sebastian Krieter, Timo Kehrer, Elias Kuiter | June 21, 2023







## Recap: Quality Assurance [Ludewig and Lichter 2013]



### Lectures on Quality Assurance

how to **avoid** variability bugs (esp. feature interactions) . . .

- with processes [Lecture 8] (e.g., domain scoping)
- with guidelines [Lecture 9]

how to find variability bugs . . .

- statically [Lecture 10]
- dynamically [Lecture 11]
  - challenges of product-line testing in Part a
  - black-box testing in Part b
  - ullet white-box testing in Part c

# 11. Product-Line Testing

## 11a. Challenges of Product-Line Testing

Recap: Software Testing

Test-Case Design in Single-System Engineering

Testing All Configurations

Testing One Configuration

Sample-Based Testing

Summary

11b. Combinatorial Interaction Testing

11c. Solution-Space Sampling

## **Recap: Software Testing**

### **Software Testing**

[Sommerville]

"Testing is intended to show that a program does what it is intended to do and to discover program defects before it is put into use."

### **Validation Testing**

[Sommerville]

"Demonstrate to the developer and the customer that the software meets its requirements."

### **Defect Testing**

[Sommerville]

"Find inputs or input sequences where the behavior of the software is incorrect, undesirable, or does not conform to its specification."

### **Stages of Testing**

[Sommerville]

- "Development testing, where the system is tested during development to discover bugs and defects"
- "Release testing, where a separate testing team tests a complete version of the system before it is released to users"
- "User testing, where users or potential users of a system test the system in their own environment"

## Manual vs Automated Testing

[Sommerville]

"In manual testing, a tester runs the program with some test data and compares the results to their expectations. [...] In automated testing, the tests are encoded in a program that is run each time the system under development is to be tested."

## Recap: Test-Case Design

#### **Test Case**

[Ludewig and Lichter 2013]

In a test, a number of test cases are executed, whereas each test case consists **input values** for a single execution and **expected outputs**. An **exhaustive test** refers a test in which the test cases exercise all the possible inputs.

### **Systematic Test**

[Ludewig and Lichter 2013]

A systematic test is a test, in which

- 1. the **setup** is defined,
- 2. the inputs are chosen systematically,
- the results are documented and evaluated by criteria being defined prior to the test.

#### Goal

[Ludewig and Lichter 2013]

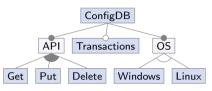
Detect a large number of failures with a low number of test cases. A test case (execution) is positive, if it detects a failure, and successful if it detects an unknown failure.

#### An ideal test case is ...

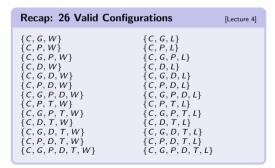
[Ludewig and Lichter 2013]

- representative: represents a large number of feasible test cases
- failure sensitive: has a high probability to detect a failure
- non-redundant: does not check what other test cases already check

# **Testing All Configurations**



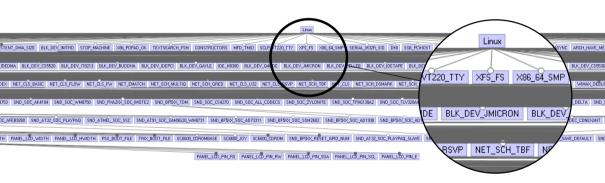
 $Transactions \rightarrow Put \lor Delete$ 



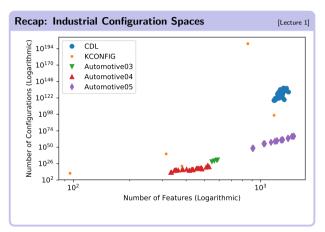
#### Discussion

- only feasible for small product lines (few valid configurations)
- redundant test effort
- large product lines: not feasible to generate and compile all configurations
  - (some) large product lines: even number of valid configurations is unknown

## Recap: Feature Model of the Linux Kernel



# **Testing All Configurations**



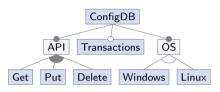
Why being complete on the configurations then?



Edsger W. Dijkstra (1972)

"Program testing can be a very effective way to show the presence of bugs, but it is hopelessly inadequate for showing their absence."

## **Testing One Configuration**



 $Transactions \rightarrow Put \lor Delete$ 

Recap: 26 Valid Configurations		[Lecture 4]
{C, G, W} {C, P, W} {C, G, P, W} {C, D, W} {C, G, D, W} {C, P, D, W} {C, P, T, W} {C, G, P, T, W} {C, D, T, T, W}	{C, G, L} {C, P, L} {C, P, L} {C, G, P, L} {C, G, D, L} {C, G, P, D, L} {C, P, T, L} {C, P, T, L} {C, C, P, T, L}	
{C, G, D, T, W} {C, P, D, T, W} {C, G, P, D, T, W}	{C, G, D, T, L} {C, P, D, T, L} {C, G, P, D, T, L}	

#### Discussion

- applicable to large product lines
- no redundant test effort (from configurations)
- strategy in practice: all-yes-config (configuration with many features selected)
- often unfeasible to test all features wit a single configuration (e.g., Windows and Linux)
- ⇒ unnoticed feature interactions

[Lecture 9]

### What about interactions with missing features?



## **Sample-Based Testing**

#### Intuition

- to analyze the product line, just analyze some products
- sample refers to a subset of all valid configurations
- common technique to test a product line
- sample configurations chosen by experts, randomly, or systematically

### **Advantages and Challenges**

- + lower effort than testing all configurations
- + higher chance to detect defects than testing one configuration
- how many configurations to test? which configurations to test?



# Challenges of Product-Line Testing – Summary

#### Lessons Learned

- recap on software testing and test-case design
- testing all configurations
- testing one configuration
- sample-based testing

### **Further Reading**

- Varshosaz et al. 2018: overview on sampling literature
- Sampling Database: database on sampling algorithms and evaluations

#### **Practice**

Recap on feature interactions: What are examples of interactions that cannot be detected statically (cf. Lecture 10) and could be missed when testing a single configuration only?

# 11. Product-Line Testing

11a. Challenges of Product-Line Testing

## 11b. Combinatorial Interaction Testing

Pairwise Interaction Testing
T-Wise Interaction Testing
Algorithms for Combinatorial Interaction Testing
Efficiency of Combinatorial Interaction Testing
Effectiveness of Combinatorial Interaction Testing
Summary

11c. Solution-Space Sampling

# **Recap: Black-Box Testing**

#### Motivation

[Ludewig and Lichter 2013]

- source code not always available (e.g., outsourced components, obfuscated code)
- errors are not equally distributed

### **Black-Box Testing**

[Ludewig and Lichter 2013]

- test-case design based on specification
- source code and its inner structure is ignored (assumed as a black-box)

### Sample Configuration $\neq$ Test Case

- test case: concrete inputs and expected outputs for a program
- sample configuration: selection of features to derive the program
- both needed when testing product lines
- often confused in the literature
- test case derivation
  - out of scope here
  - global tests (i.e., identical for all configurations)
  - product-line implementation technique used to automatically derive configuration-specific tests

[Lecture 8]

 on next slides: idea of black-box testing applied to derive sample configuration

# **Pairwise Interaction Testing**

### Configurations with the Interaction Get $\land$ Put

```
\{C,G,W\}
                                  \{C,G,L\}
\{C, P, W\}
                                  \{C, P, L\}
\{C,G,P,W\}
                                  \{C,G,P,L\}
\{C, D, W\}
                                  \{C, D, L\}
\{C,G,D,W\}
                                  \{C,G,D,L\}
\{C, P, D, W\}
                                  \{C, P, D, L\}
\{C,G,P,D,W\}
                                  \{C,G,P,D,L\}
\{C, P, T, W\}
                                 \{C, P, T, L\}
\{C,G,P,T,W\}
                                 \{C,G,P,T,L\}
\{C, D, T, W\}
                                 \{C, D, T, L\}
\{C,G,D,T,W\}
                                 \{C,G,D,T,L\}
\{C, P, D, T, W\}
                                 \{C, P, D, T, L\}
                                 \{C,G,P,D,T,L\}
\{C, G, P, D, T, W\}
```

### **Pairwise Interaction Testing**

- create a sample S ⊆ C, in which every pairwise interaction is covered by at least one configuration
- test every configuration in S

#### **Pairwise Combinations**

- four combinations between A and B
  - both selected:  $A \wedge B$
  - one selected:  $\neg A \land B$  and  $A \land \neg B$
  - none selected:  $\neg A \land \neg B$

#### Discussion

- applicable to large product lines
- reduced redundant effort compared to testing all configurations
- full coverage guarantee (opposed to random configurations)
- still requires good test cases (program inputs)
- hard to compute small sample sets

# Pairwise Coverage



 $Transactions \rightarrow Put \lor Delete$ 

#### Interactions to Cover

- exclude abstract features (e.g., API, OS)
- exclude features contained in every configuration (e.g., C)
- exclude invalid combinations (e.g.,  $W \wedge L$ )

### **Pairwise Interactions**

```
G \wedge P
                G \wedge \neg P
                                   \neg G \land P
                                                       \neg G \land \neg P
G \wedge D
               G \wedge \neg D
                                  \neg G \land D
                                                      \neg G \land \neg D
G \wedge T
               G \wedge \neg T
                                  \neg G \wedge T
                                                     \neg G \land \neg T
G \wedge W
               G \land \neg W
                                 \neg G \land W
                                                    \neg G \land \neg W
G \wedge L
               G ∧ ¬I
                                  \neg G \wedge L
                                                    \neg G \land \neg I
              P \wedge \neg D
                                  \neg P \wedge D
                                                    \neg P \land \neg D
P \wedge D
                                  \neg P \wedge T
                                                     \neg P \land \neg T
P \wedge T
               P \wedge \neg T
P \wedge W
              P \wedge \neg W
                                  \neg P \wedge W
                                                     \neg P \land \neg W
P \wedge L
                P \wedge \neg L
                                  \neg P \wedge L
                                                     \neg P \land \neg L
               D \wedge \neg T
                                  \neg D \wedge T
                                                    \neg D \land \neg T
D \wedge T
D \wedge W
               D \wedge \neg W
                                  \neg D \wedge W
                                                    \neg D \land \neg W
               D \wedge \neg L
                                  \neg D \wedge L
                                                     \neg D \land \neg L
D \wedge L
              T \wedge \neg W
                                 \neg T \wedge W
                                                    \neg T \land \neg W
T \wedge W
T \wedge I
               T \wedge \neg I
                                  \neg T \land I
                                                     \neg T \land \neg I
                I \wedge \neg W
                                  \neg I \wedge W
```

## Pairwise Coverage with Six Configurations

```
{C, P, D, T, W}
{C, G, D, L}
{C, G, P, T, L}
{C, G, W}
{C, P, W}
{C, D, T, L}
```

## **T-Wise Interaction Testing**

### **T-Wise Interaction Testing**

- · generalization of pairwise interaction testing
- t-wise coverage: every t-wise interaction is covered by at least one configuration in the sample
- t = 1: every feature is selected and also deselected
- t = 2: pairwise interaction coverage
- t = 3: every valid combination of three features covered

### t = 3 Interactions

```
for the features G, P, and D:

G \land P \land D \neg G \land P \land D

G \land P \land \neg D \neg G \land P \land \neg D

G \land \neg P \land D \neg G \land \neg P \land \neg D

G \land \neg P \land \neg D \neg G \land \neg P \land \neg D
```

# **Algorithms for Combinatorial Interaction Testing**

### A Greedy Algorithm

idea: select configuration that cover most missing interactions in each step

- 1. randomly choose first configuration
- 2. find next optimal configuration
- 3. repeat step 2 until all interactions are covered

### **Challenges and Optimizations**

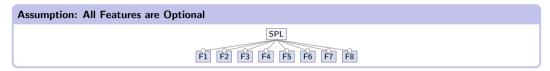
- non-deterministic: different sample for each run (cf. Step 1)
  - starting with all-yes-config? ⇒ covers more code
- iterating all valid configurations does not scale (cf. Step 2)
- greedy strategy: optimal configuration in each step does not guarantee optimal sample

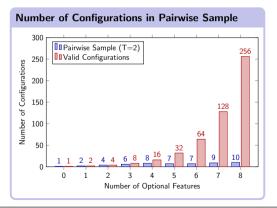
#### ICPL

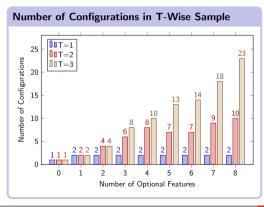
[Johansen et al. 2012]

- widespread greedy algorithm
- iterates over all interactions
  - identifies core and dead features early
  - identifies invalid and already covered interactions
  - utilizes parallelization
- incrementally increases *t* up to desired value
- performance shown on next slides

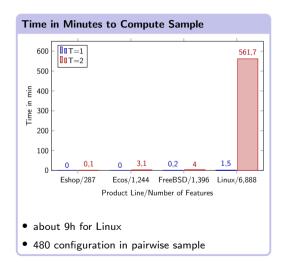
## Efficiency of Combinatorial Interaction Testing [Johansen et al. 2012]







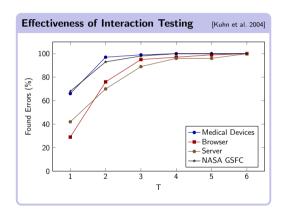
## Efficiency of Combinatorial Interaction Testing [Johansen et al. 2012]



## **Number of Configurations in Sample** 00T=1 500 00T=2 Number of Configurations 400 300 200 100 Eshop/287 Ecos/1,244 FreeBSD/1,396 Linux/6,888 Product Line/Number of Features

- Linux kernel v2.6.28.6 (February 2009)
- 6,888 features
- 187,193 clauses in conjunctive normal form

# **Effectiveness of Combinatorial Interaction Testing**



#### Trade-Off

large t: high coverage (more effective) small t: low testing effort (more efficient)

# **Combinatorial Interaction Testing – Summary**

#### Lessons Learned

- recap on black-box testing
- combinatorial interaction testing: pairwise testing, t-wise testing
- efficiency: number of configurations, time to compute sample
- effectiveness: percentage of found defects

### **Further Reading**

- Johansen et al. 2012 popular t-wise sampling algorithm ICPL
- Krieter et al. 2020 alternative t-wise sampling algorithm YASA

#### **Practice**

Why is it hard to find a good trade-off between efficiency and effectiveness?

# 11. Product-Line Testing

11a. Challenges of Product-Line Testing

11b. Combinatorial Interaction Testing

## 11c. Solution-Space Sampling

Coverage in Single-System Engineering

Coverage of Ifdef Blocks

Presence-Condition Coverage

Overview on Coverage Criteria

Input for Sampling Algorithms

Summary

FAQ

## Recap: Coverage in White-Box Testing [Ludewig and Lichter 2013]

### White-Box Testing

- inner structure of test object is used
- idea: coverage of structural elements
  - code translated into control flow graph
  - specific test case (concrete inputs) derived from logical test case (conditions) derived from path in control flow graph

## Coverage Criteria

case

- statement coverage : all statements are executed for at least one test
- branching coverage: statement coverage and all branches of branching statement are executed
- 3. term coverage :

branching coverage and all terms used in a branching statement (n) are combined exhaustively  $(2^n)$  (simplified)

```
class ControlUnit {
                                                //#if DirectedCall
                                                                                  31
  Flevator elevator:
                                                sortOueue():
                                                                                        //#if Service
                                       17
  ElevatorState state, nextState:
                                       18
                                                //#endif
                                                                                        boolean serviceNextState() {...}
  //#if FTFO
                                       19
                                                                                  34
                                                                                        //#endif
  Reg reg = new Reg():
                                       20
                                                                                  35
                                                                                        //#if Sabbath
  //#elif DirectedCall
                                       21
                                             void calculateNextState() {
                                                                                        boolean sabbathNextState() {...}
  Reg reg = new UndReg(this):
                                       22
                                              //#if Sabbath
                                                                                  37
                                                                                        //#endif
  Rea drea = new DirRea(null):
                                              if (sabbathNextState()) return:
                                                                                        //#if DirectedCall
                                       23
  //#else
                                              //#endif
                                                                                        void callButtonsNextState(Reg. d)
                                       24
  Reg reg = new Reg(this):
                                              //#if Service
                                       25
                                                                                             {...}
  //#endif
                                              if (serviceNextState()) return:
                                                                                        void sortOueue() {...}
                                       26
  void run() {
                                       27
                                              //#endif
                                                                                        //#endif
   while (true) {
                                       28
                                              //#if FIFO
                                                                                  42 3
     calculateNextState():
                                       29
                                              callButtonsNextState(dreg):
     setDirection(nextState):
                                              //#endif
```

- Line 29: compiler error (i.e., field dreg undefined) when FIFO ∧ ¬DirectedCall
- Line 8: null pointer exception when *DirectedCall* ∧ ¬*FIFO*
- both problems detectable with pairwise coverage, but presence conditions are more complicated in practice
- also: pairwise coverage often too much effort for large configuration spaces / continuous integration

### Coverage of Ifdef Blocks

[Tartler et al. 2012]

• every block selected for at least one configuration in the sample (cf. statement coverage)

# **Presence-Condition Coverage**

#### **Presence-Condition Coverage**

[Krieter et al. 2022]

- application of t-wise interaction testing to presence conditions
- recap presence condition: formula specifying exactly those configurations under which a block is present
- t-wise presence condition coverage: every t-wise interaction of presence conditions is covered by at least one configuration in the sample
- t = 1: every block is selected and also deselected (i.e., more than Tartler's coverage of ifdef blocks)
- t = 2: every combination of two blocks covered
- t = 3: every combination of three blocks covered

### T=3 Presence-Condition Interactions

for the blocks a, b, and c with presence conditions

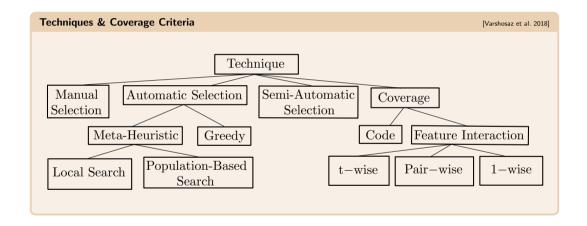
 $\begin{array}{lll} A, \ B, \ \text{and} \ C: \\ A \wedge B \wedge C & \neg A \wedge B \wedge C \\ A \wedge B \wedge \neg C & \neg A \wedge B \wedge \neg C \\ A \wedge \neg B \wedge C & \neg A \wedge \neg B \wedge C \\ A \wedge \neg B \wedge \neg C & \neg A \wedge \neg B \wedge \neg C \\ \end{array}$ 

### **Presence-Condition Coverage**

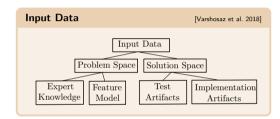
[Krieter et al. 2022]

- coverage of solution space (not problem space)
- aka. solution-space sampling
- for same t: often fewer configurations and similar effectiveness than feature interaction coverage
- also feasible by translating presence conditions into feature model [Hentze et al. 2022]

# Overview on Coverage Criteria



## **Input for Sampling Algorithms**



### **Further Domain Knowledge**

[Varshosaz et al. 2018]

- in addition to feature model
- e.g., configurations chosen by experts
- e.g., specialized feature model for sampling

### Part 2: Combinatorial Interaction Testing

- (Problem-Space Sampling)
- feature model used to consider only valid configurations

### Part 3: Solution-Space Sampling

- mapping from features to implementation artifacts
- feature model used to consider only valid configurations

### **Combinatorial Reduction of Tests**

[Kim et al. 2011]

- which configurations matter for each test?
- analyze unit tests and impl. artifacts
- feature model used to consider only valid configurations

# **Solution-Space Sampling – Summary**

#### Lessons Learned

- recap on white-box testing and coverage criteria
- coverage of ifdef blocks
- t-wise presence condition coverage
- overview on techniques, coverage criteria, input data for sampling

### **Further Reading**

- Tartler et al. 2012: covering every ifdef block (but not their absence)
- Krieter et al. 2022: solution-space sampling as discussed in this part
- Hentze et al. 2022: translation of presence conditions into feature model + reuse of problem-space sampling

#### **Practice**

Does the order of configurations matter during testing? [Al-Hajjaji et al. 2019]

# **FAQ** – 11. Product-Line Testing

### Lecture 11a

- What is the goal of quality assurance for software product lines?
- How can product lines be tested?
- Why is testing product lines challenging?
- What are (dis-)advantages of testing all configurations?
- What are (dis-)advantages of testing only one configuration?
- What is sample-based testing?
- What is a sample?
- How can a sample be computed?

#### Lecture 11b

- How is black-box testing used for testing product lines?
- What is the difference between a test configuration and a test case?
- What are (dis-)advantages of combinatorial interaction testing?
- What is pairwise interaction testing?
- What is t-wise interaction testing?
- When does a sample achieve 100% pairwise coverage?
- How can a t-wise sample be computed?

### Lecture 11c

- How can white-box testing be used for testing product lines?
- What are potential problems with t-wise interaction testing?
- What is presence condition coverage?
- What are different techniques for t-wise sampling?
- Which additional inputs can be used for sampling algorithms?
- How efficient and how effective are sampling algorithms?